



<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10726882</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>ARIK ET AL.</p>
	<p>Examiner</p> <p>Han, Jason M</p>	<p>Art Unit</p> <p>2875</p>

Class	SubClass	Date	Examiner
257	88, 706	7/14/2006	JMH

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Search Notes 	Application/Control No. 10726882	Applicant(s)/Patent Under Reexamination ARIK ET AL.
	Examiner Han, Jason M	Art Unit 2875

Notes	Date	Examiner
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Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	7/14/2006	JMH
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